White paper

BASF Ultrasint® TPU01 for the HP Jet Fusion 5200 Series 3D Printing Solution



Dimensional Capability



Introduction

At HP, we are committed to providing part designers and part manufacturers with the technical information and resources needed to enable them to unlock the full potential of 3D printing and prepare them for the future era of digital manufacturing.

The aim of this white paper is to provide you with information on the dimensional capabilities that can be achieved with the HP Jet Fusion 5200 Series 3D Printing Solution with BASF Ultrasint[®] TPU01.¹

In this white paper, you will find:

- Tolerances in XY and Z for nominal dimensions ranging from 0 mm to 80 mm that can be achieved with the HP Jet Fusion 5200 Series 3D Printing Solution, according to a process capability index,
- A detailed explanation of the test conditions under which these values were obtained, and
- Additional information on the concept of process capability and dimensional tolerancing, and a glossary of key terms used.

HP Jet Fusion 5200 Series 3D Printing Solution dimensional capability performance

Test job

The dimensional capability performance of the HP Jet Fusion 5200 Series 3D Printing Solution has been characterized using the **HP dimensional capability characterization job**, which contains 122 diagnostic parts spread throughout the printable volume. The job includes three different types of diagnostic parts and a total of 1,524 dimensions.



Figure 1. HP dimensional capability characterization job

Performance results for BASF Ultrasint® TPU01

Table 1 shows the dimensional tolerances obtained during the characterization for a target process capability of $C_{nk} = 1.33$ (4 sigma).

	Nominal dimension											
Tolerances for C _{pk} = 1.33 ⁱⁱⁱⁱⁱⁱ (in mm)	0 – 3	0 mm	30 – !	50 mm	50 – 80 mm							
	XY	Z	ХҮ	Z	ХҮ	Z						
With the default setting for the HP Jet Fusion 5200 Series 3D Printing Solution	±0.44	±1.05	±0.52	±1.35	± 0.66	± 1.80						

i. Based on internal testing and measured using the HP dimensional capability characterization job. Results may vary with other jobs and geometries. *ii.* Using BASF Ultrasint® TPU01 material, 20% refresh ratio, Balanced print profile, hot unpack, and measured after sandblasting with glass beads 300-400 µm at 5-6 bars.

iii. Following all HP-recommended printer setup and adjustment processes and print heads aligned using semi-automatic procedure.

Table 1. Dimensional capabilities for BASF Ultrasint[®] TPU01. Target process capability of C_{nk} = 1.33.

Table 2 shows the dimensional tolerances if the process capability target is set to C_{pk} = 1.00 (3 sigma).

	Nominal dimension											
Tolerances for C _{pk} = 1.00 ⁱⁱⁱⁱⁱⁱ (in mm)	0 – 3	0 mm	30 – 9	50 mm	50 – 80 mm							
	ХҮ	Z	ХҮ	Z	ХҮ	Z						
With the default setting for the HP Jet Fusion 5200 Series 3D Printing Solution	±0.35	±0.90	±0.40	±1.15	± 0.50	± 1.50						
i. Based on internal testina and measured usina the HP dimensional capability characterization iob. Results may vary with other iobs and acometries.												

ii. Using BASE Ultrasint® TPU01 material, 20% refresh ratio, Balanced print profile, hot unpack, and measured after sandblasting with glass beads 300-400 µm at 5-6 bars.

iii. Following all HP-recommended printer setup and adjustment processes and print heads aligned using semi-automatic procedure.

Table 2. Dimensional capabilities for BASF Ultrasint[®] TPU01. Target process capability of C_{pk} = 1.00.

Appendix 1: Understanding process capabilities

Process capability determines whether a process meets a specification. The process capability index or process capability ratio or C_{pk} is a statistical measure of process capability. It quantifies the ability of a process to produce output within specification limits.

When talking about a dimensional specification, the C_{pk} measures the statistical probability that a certain process produces a dimension within its tolerance range. The higher the C_{pk} value the better, meaning that more measurements will be within its tolerance range.

For a process to be capable, it needs to be both repeatable and accurate.

Repeatability is how close multiple measurements are to each other (also called precision).

Accuracy is how close a measurement value is to the specified nominal.

The capability of a process is then a function of two parameters:

- How repeatable it is compared to the width of the specification limits, measured by the C
- How accurate it is, measured by the bias



Figure 2. Relationship between bias and variability

This concept only holds meaning for processes that are in a state of statistical control with an output that is approximately normally distributed.

Both conditions happen when dealing with the dimensional quality control of HP MJF–produced parts where the output is the dimensional value of the different geometrical features of a part.

Dimensional quality control processes define an upper specification limit (USL) and lower specification limit (LSL), also called the "tolerance range" of the process. The target of the process is the center of this range, typically the nominal dimension value.

The objective to have a well-controlled dimensional process is to have its normal distributed population of measurements:

- With a variability (calculated as standard deviation) that "fits" in the tolerance range. **C**_p measures how well the variability fits within the tolerance range.
- With a mean (average) as close as possible to the target. The deviation is measured by the bias.

Only if both conditions are met, process capability measured by C_{pk} is considered good:



Figure 3. Process capability C_{nk} scenarios

The mathematical calculation of these parameters is as follows:

$$C_{p} = \frac{Specification width}{Process width} = \frac{(USL - LSL)}{6\sigma}$$

Standard deviation estimates the sigma and quantifies the variability and dispersion of the process.

 C_{n} should always be greater than 1.00 for the variability to fit within the tolerance range.

$$C_{pk} = m \left[in \frac{[USL - \mu]}{3 \cdot \sigma}, \frac{[\mu - LSL]}{3 \cdot \phi} \right]$$

The statistical mean estimates the mu (μ).

Therefore:

- $\cdot C_{_{DK}}$ "measures" the distance of the mean to the closer specification limit, which could be the upper or the lower limit.
- C_{pk} takes into account how centered the process is $(C_{pk} \le C_p)$.
- For a perfectly centered process, $C_p = C_{pk}$.
- If $C_p > C_{pk}$, it is possible to increase the C_{pk} by readjusting the mean of the process.

	C _{pk}	Sigma level	Dimensions within specs (%)	Dimensions out of specs (units per million)	Part yield for a part with 10 dimensions (%)	
100%	0.33	1	68.27	317,300	2.20	
inspection	0.67	2	95.45	45,500	62.77	
	1.00	3	99.73	2,700	97.33	
Statistical	1.33	4	99.9937	63	99.94	De
process	1.50	5	99.99966	3.4	100	
control	1.67	6	99.99997	0.6	100	

Table 3 displays the relevant $C_{_{Dk}}$ values and their correlation with process yields:

Table 3. C_{pk} and process yield correlation

For a part to be considered good, all the specified dimensions need to be within tolerances. Therefore, the part yield is a metric that can be calculated as the statistical sum of the single dimension success rate. In the previous table, an example for a part with 10 dimensions is shown in the right column.

For **C**_{pk} **values below 1.00**, the yield is such that the best quality control method is **100% inspection**, and the general fabrication process is to over-produce and send only the parts that meet the tolerance requirements. This is costly but it is a reasonable process, especially for low-volume production.

For C_{pk} values above 1.00 (3 sigma), the dimensional success rate and the yield begin to approach each other, and statistical process control starts to become a viable option. This means that after the process has demonstrated that it is statistically and consistently achieving C_{nk} above 1.00 for all dimensions, one could move to auditing random parts per each lot of parts.

Generally, a C_{pk} of 1.33 (4 sigma) is desired to ensure enough of a margin for statistical process control, especially when dealing with multi-part complex mechanisms.

Appendix 2: Dimensional requirements & IT grades

The International Tolerance grades (IT grades) defined in ISO 286/ANSI B4.2-1978 provide standardized tolerance ranges. The smaller the IT grade, the smaller the tolerance range, meaning better dimensional performance (less variability).

Each IT grade has a tolerance range that varies depending on the nominal value of the dimension. The larger the specified dimension, the larger the tolerance range for accuracy.

Dimen	sion (mm)	IT1	IT2	IT3	IT4	IT5	IT6	IT7	IT8	IT9	IT10	IT11	IT12	IT13	IT14	IT15
Above	Up to and including						μm		Toler			mm				
-	3	0.8	1.2	2	3	4	6	14	10	25	40	60	0.10	0.14	0.25	0.4
3	6	1	1.5	2.5	4	5	8	18	12	30	48	75	0.12	0.18	0.30	0.48
6	10	1	1.5	2.5	4	6	9	22	15	36	58	90	0.15	0.22	0.36	0.58
10	18	1.2	2	3	5	8	11	27	18	43	70	110	0.18	0.27	0.43	0.70
18	30	1.5	2.5	4	6	9	13	33	21	52	84	130	0.21	0.33	0.52	0.84
30	50	1.5	2.5	4	7	11	16	39	25	62	100	160	0.25	0.39	0.62	1.00
50	80	2	3	4	8	13	19	46	30	74	120	190	0.30	0.46	0.74	1.20
80	120	2.5	4	6	10	15	22	54	35	87	140	220	0.35	0.54	0.87	1.40
120	180	3.5	5	8	12	18	25	63	40	100	160	250	0.40	0.63	1.00	1.60
180	250	4.5	7	10	14	22	29	72	46	115	185	290	0.46	0.72	1.15	1.85
250	315	6	8	12	16	23	32	81	52	130	210	320	0.52	0.81	1.30	2.10
315	400	7	9	13	18	25	36	89	57	140	230	360	0.57	0.89	1.40	2.30
400	500	8	10	15	20	27	40	97	63	155	250	400	0.63	0.97	1.55	2.50
500	630	9	11	16	22	32	44	100	70	175	280	440	0.70	1.10	1.75	2.80

Table 4. Standard international tolerance grades



Figure 4. Tolerance range vs. dimension length

IT grades provide a standardized reference to compare typical manufacturing process capability in terms of dimensional tolerance for a given dimension, as shown in the following table.

				Meas	uring	tools			Material									
IT Grade	01	0	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16
	Detter									Fits				L	arge n to	nanufa leranc	icturir es	ıg
	Bette	Better 🚽																

Table 5. IT Grades for measuring tools & materials

Appendix 3: Key terms

- **Process capability:** Statistical measurement of a process's ability to produce parts within specified limits on a consistent basis.
- International Tolerance Grade (IT Grade): Grade used to identify the tolerances a given industrial process can produce for a given dimension.
- Repeatability: Ability of a process to consistently produce the same output; in this case, the same part dimensions.
- Bias: Difference between the average of the population for a given dimension and the target value of that dimension.
- C_p: Process capability index that measures of the ability of a process to produce consistent results—the ratio between the permissible spread and the actual spread of a process. This does not take into account how well the output is centered on the target (nominal) value.
- C_{pk} : Process capability index that estimates what the process is capable of producing, considering that the process mean may not be centered between the specification limits. C_{pk} < 0 if the process mean falls outside of the specification limits.

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